

Notice of References Cited

Application/Control No.

10/774,606

Applicant(s)/Patent Under
Reexamination
NAKAI, SHINYA

Examiner

NGUYEN VO

Art Unit

2618

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0030555	03-2002	Mandai et al.	333/133
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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